Notice of Allowability	Application No.	Applicant(s)	
	10/765,599	BARNETT ET AL.	
	Examiner	Art Unit	
	Long Nguyen	2816	
The MAILING DATE of this communication appear All claims being allowable, PROSECUTION ON THE MERITS IS (herewith (or previously mailed), a Notice of Allowance (PTOL-85) of NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIC of the Office or upon petition by the applicant. See 37 CFR 1.313	OR REMAINS) CLOSED in this apport or other appropriate communication GHTS. This application is subject to and MPEP 1308.	olication. If not include will be mailed in due withdrawal from issu	ed course. THIS
1. This communication is responsive to the amendment filed o	on 4/12/06 and the telephone intervi	<u>ew on 6/7/06</u> .	
2. The allowed claim(s) is/are <u>1,2,5,6,11 and 12</u> .			
3.			
Attachment(s) 1. Notice of References Cited (PTO-892) 2. Notice of Draftperson's Patent Drawing Review (PTO-948) 3. Information Disclosure Statements (PTO-1449 or PTO/SB/08 Paper No./Mail Date 4. Examiner's Comment Regarding Requirement for Deposit of Biological Material	5. ☐ Notice of Informal P 6. ☑ Interview Summary Paper No./Mail Dat 7. ☑ Examiner's Amendr 8. ☑ Examiner's Stateme 9. ☐ Other	(PTO-413), le <u>1/1/06.</u> nent/Comment	

EXAMINER'S AMENDMENT

1. An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

Authorization for this examiner's amendment was given in a telephone interview with Mr. Jim Brady on 6/7/06.

The application has been amended as follows:

In The Claims

Claim 1, line 17, "device is a" has been changed to --devices are--.

Claim 1, line 17, "device and" has been changed to --devices and--.

Claim 1, line 18, "device is a" has been changed to --devices are--.

Claim 1, line 18, "device." has been changed to --devices.--.

Claim 5, lines 7-9, "a plurality of circuit elements having asymmetric signal handling characteristics coupled in parallel and establishing a plurality of parallel asymmetric signal paths; and" has been changed to --first and second circuit elements coupled in parallel, said first circuit elements having symmetric signal handling characteristics, said second circuit elements having symmetric signal handling characteristics, said first and second circuit elements having asymmetric signal handling characteristics, said first and second circuit elements in each respective signal treating circuit segment of said first and second signal treating circuit segments coupled in parallel for establishing a plurality of parallel asymmetric signal paths; and--.

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Claim 5, line 11, "selected" has been changed to -said first and second--.

Claim 5, line 12, "of said plurality of circuit elements" has been deleted.

Claim 5, lines 13-16, "effecting substantially balanced signal handling among particular circuit elements of said selected circuit elements having symmetric signal handling characteristics in each said respective signal treating circuit segment," has been changed to --effect operating said first circuit elements in substantial symmetry and said second circuit elements in substantial symmetry,--.

Claim 5, line 17, "said two" has been changed to --said first--.

Claim 5, line 17, "are a" has been changed to --are--.

Claim 5, line 17, "transistor and a" has been changed to --transistors and said second circuit elements are--

Claim 5, line 18, "transistor." has been changed to --transistors.--.

Claim 11, line 7, "including two" has been changed to --including first and second--.

Claim 11, lines 8-9, "said two semiconductor circuit elements having different signal handling characteristics; and" has been changed to --said first semiconductor circuit elements having like signal handling characteristics, said second semiconductor circuit elements having like signal handling characteristics, said first and second semiconductor circuit elements of each signal handling section of said two signal handling sections having different signal handling characteristics; and--.

Claim 11, line 12, "appropriate" has been deleted.

Claim 11, lines 12-14, "respective semiconductor circuit elements of said two semiconductor circuit elements having like signal handling characteristics in substantial

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symmetry," has been changed to --said first semiconductor circuit elements in substantial symmetry and said second semiconductor circuit elements in substantial symmetry,--.

Claim 11, line 15, "one of said two" has been changed to --said first--.

Claim 11, line 15, "is a" has been changed to --are--.

Claim 11, line 16, "transistor and one of said two" has been changed to --transistors and said second--.

Claim 11, line 16, "is a bipolar transistor." has been changed to -are bipolar transistors--.

Reasons For The Above Changes

The above changes have been made so that the claims are clear.

REASONS FOR ALLOWANCE

2. Claims 1, 2, 5, 6, 11, and 12 are allowed.

Claims 1, 5 and 11 are allowed because the prior art of record fails to disclose or suggest the limitations that the first circuit/transistor devices/elements are metal-oxide transistors and the second circuit/transistor devices/elements are bipolar transistors in combination with the rest of the limitations recited in claims 1, 5 and 11.

Claims 2, 6 and 12 are allowed because they depend on claims 1, 5 and 11, respectively.

Conclusion

3. Any inquiry concerning this communication or earlier communications from the examiner should be directly to Examiner Long Nguyen whose telephone number is (571) 272-1753. The Examiner can normally be reached on Monday to Thursday from 8:00am to 6:30pm.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Tim Callahan, can be reached at (571) 272-1740. The fax number for this group is (571) 273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

LONG NGUYEN
PRIMARY EXAMINER